


Search Notes 	Application/Control No. 10582532	Applicant(s)/Patent Under Reexamination WEE, ARNSTEIN
	Examiner Wachsman, Hal D	Art Unit 2857

SEARCHED			
Class	Subclass	Date	Examiner
702	45	12-5-07	HW
702	50, 100	12-6-07	HW

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS (see printout)	8-30-07	HW
EAST (See Search History Printout)	12-5-07	HW
IEEE (See Search History Printout)	12-5-07	HW
340/451, 603, 606, 611, 626, 584; 700/285, 266, 273, 281, 282; 374/141-143; 210/85, 90, 97; 137/1, 3, 88, 100, 87.03, 87.04, 551, 554, 557, 559; 377/21; 324/694, 693, 637, 640, 642, 643, 698, 634, 664, 667, 669, 670, 674, 683, 684, 685; 73/152.18, 152.21, 152.22, 152.29, 152.33, 152.51 - 152.53, 152.55, 861, 861.01-861.04, 861.11, 861.12, 861.15, 861.351, 861.356, 195-197, 200, 202.5, 204.11, 204.14, 204.18, 204.19, 861.63, 488, 700, 712, 32R, 30.01 - 30.04, 31.04, 1.02, 1.16, 1.34; .	12-6-07	HW
73/1.35, 1.37, 1.44, 1.57, 1.59, 37, 61.64, 61.67, 61.44, 61.73, 64.44, 61.46, 61.47, 622, 152.01; 702/49, 46, 47, 48, 38, 53-55, 57-60, 65, 72, 85, 75, 98, 99, 104-106, 114, 127, 130, 138, 140, 182, 183, 185, 187, 189, 12 (text search only)	12-6-07	HW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner